

The 21st Korean Conference on Semiconductors
제21회 한국반도체학술대회
February 24–26, 2014 / Hanyang University, Seoul, Korea

[WP2] Poster 3

Date	Feb. 26, 2014 (Wed.)
Place	Room I / 제1공학관 408호 (# 408, Engineering Building I)

- WP2-1 Influence of Gate Dielectrics on Electrical Characteristics of Solution-Processed ZnO Transistors**
저자: Xue Zhang¹, Jaehoon Park¹, Hyunji Shin², Dong Wook Kim², Jong Sun Choi², Jae Eun Hwang³, and Hong Doo Kim³
소속: ¹Department of Electronic Engineering, Hallym University, ²Department of Electrical, Information and Control Engineering, Hongik University, ³Department of Display Materials Engineering, Kyunghee University
- WP2-2 Purge-Time-Induced Changes in Preferred Orientation of Zinc Oxide Thin Films Grown by Atomic Layer Deposition**
저자: Hui Kyung Park and Jaeyeong Heo
소속: Department of Materials Science and Engineering, Chonnam National University
- WP2-3 Flexible Micro-Scale Organic Field Effect Transistors Fabricated Achieved via Orthogonal Photolithography**
저자: Jingon Jang¹, Younggul Song¹, Hyuntaek Oh², Daekyoung Yoo¹, Jin-Kyun Lee², and Takhee Lee¹
소속: ¹Department of Physics and Astronomy, Seoul National University, ²Department of Polymer Science and Engineering, Inha University
- WP2-4 Gate Dielectric Effects on Electrical Characteristics of 6,13-Bis(Triisopropylsilylethynyl)-Pentacene Transistors**
저자: Hyunji Shin¹, Dongwook Kim¹, Jaehoon Park², and Jong sun Choi¹
소속: ¹ Department of Electrical, Information and Control Engineering, Hongik University, ² Department of Electronic Engineering, Hallym University
- WP2-5 Deposition of Thicker Ferroelectric (Hf,Zr)O₂ Thin Films using Al₂O₃ Inter-Layer**
저자: Han Joon Kim, Min Hyuk Park, Yu Jin Kim, Taehwan Moon, and Cheol Seong Hwang
소속: Department of Material Science & Engineering and Inter-university Semiconductor Research Center, Seoul National University
- WP2-6 Improving Conformality of SrRuO₃ Film Grown by Combined ALD SrO and CVD RuO₂ or Ru Layers**
저자: Cheol Hyun An, Woojin Jeon, Woongkyu Lee, Yeon Woo Yoo, and Cheol Seong Hwang
소속: Department of Materials Science and Engineering and Inter-university Semiconductor Research Center, Seoul National University
- WP2-7 Microwave-Annealing Effects of Solution-Processed HfO_x Thin Film as a Resistive Switching for ReRAM**
저자: Ki-Hyun Jang, Se-Man Oh, Se-Ho Kim, and Won-Ju Cho
소속: Department of Electronic Materials Engineering, Kwangwoon University

The 21st Korean Conference on Semiconductors
제21회 한국반도체학술대회
February 24–26, 2014 / Hanyang University, Seoul, Korea

[WP2] Poster 3

Date	Feb. 26, 2014 (Wed.)
Place	Room I / 제1공학관 408호 (# 408, Engineering Building I)

- WP2-8 Surface Reaction Chemistry during Atomic Layer Deposition of Sc_2O_3 and Gd_2O_3 from Cp-Based Metal Precursors**
저자: Jeong Hwan Han^{1,2}
소속: ¹Present address: Advanced Materials Division, Korea Research Institute of Chemical Technology, ²Imec
- WP2-9 Characterization of Charge Trapping and Current Conduction Mechanism in Hf-Aluminate for 3D-Stacked NAND Flash Memory**
저자: Jinho Oh, Heedo Na, and Hyunchul Sohn
소속: Department of Materials Science and Engineering, Yonsei University
- WP2-10 A Novel Low-Temperature Treatment on Solution-Derived Amorphous InGaZnO Thin-Film Transistor for Flexible Display**
저자: Yeong-Hyeon Hwang, Sung-Wan Moon, Ja-Kyung Gu, and Won-Ju Cho
소속: Department of Electronic Materials Engineering, Kwangwoon University
- WP2-11 The Speed Improvement of In_3SbTe_2 Phase Change Material by Doping Bi Element**
저자: Minho Choi¹, Yong Tae Kim², and Jinho Ahn¹
소속: ¹Department of Materials science and engineering, Hanyang University, ²Semiconductor Materials and Device Laboratory, Korea Institute of Science and Technology
- WP2-12 High Performance Solution-Processed MoS_2 Field Effect Transistor by Two-Step Annealing**
저자: Juyeon Won, Chul-Kyu Lee, Byeong-Geun Son, Hyo Jin Kim, Soyeon Je, and Jae-Kyeong Jeong
소속: Department of Materials Science and Engineering, Inha University
- WP2-13 Solution Processed CuO_x and Its Transport Characteristics**
저자: Si-Hong Kim, Myung-Ji Kim, Ji-Su Ahn, and Deok-Kee Kim
소속: Department of Electrical Engineering, Sejong University
- WP2-14 Improvement in Bias Stability of Amorphous IGZO Thin Film Transistors by High Pressure H_2O_2 Annealing**
저자: Ji Hun Song, Chang-Kyu Lee, Ah Young Hwang, and Jae Kyeong Jeong
소속: Department of Materials Science and Engineering, Inha University
- WP2-15 Soluble-Processed Zr-La-O/ SiO_2 Gate Dielectrics at 180°C for Flexible Metal Oxide Transistors**
저자: Soyeon Je, Byeong-Guen Son, Hyojin Kim, Juyeon Won, and Jaekyeong Jeong
소속: Department of Materials Science and Engineering, Inha University

The 21st Korean Conference on Semiconductors
제21회 한국반도체학술대회
February 24–26, 2014 / Hanyang University, Seoul, Korea

[WP2] Poster 3

Date	Feb. 26, 2014 (Wed.)
Place	Room I / 제1공학관 408호 (# 408, Engineering Building I)

- WP2-16 Atomic Layer Deposition of Ruthenium Thin Film from Ru Precursor**
저자: Hyo Jun Jung^{1,2}, Eun Ae Jung¹, Jeong Hwan Han¹, Bo Keun Park¹, Sun Sook Lee¹, Jin Ha Hwang², Chang Gyoung Kim¹, Ki Seok An¹, and Taek Mo Chung¹
소속: ¹Advanced Materials Division, Korea Research Institute of Chemical Technology, ²Department of Materials Science and Engineering, Hongik University
- WP2-17 Anomalous Behavior of Oxygen Gas Ratio-Dependent Field Effect Mobility in In-Zn-Sn-O Thin Film Transistor**
저자: Ah Young Hwang, Chang-Kyu Lee, Ji Hun Song, and Jae Kyeong Jeong
소속: Department of Materials Science and Engineering, Inha University
- WP2-18 Effect of HfO₂ Charge Trap Layer and Al₂O₃ Blocking Layer Thickness on MAHAS Structure Memory Characteristics**
저자: Heedo Na, Jinho Oh, Kyumin Lee, and Hyunchul Sohn
소속: Department of Material Science and Engineering, Yonsei University
- WP2-19 The Effects of Post Annealing on the Schottky Behaviors of Atomic Layer Deposited Ruthenium on the Si Substrate**
저자: Donghwan Lim¹, Moon-Suk Choi¹, Dohyung Kim¹, Youngil Gil¹, Woosuk Jung¹, Seong Chan Heo², and Changhwan Choi¹
소속: ¹ Division of Materials Science and Engineering, Hanyang University, ² SK hynix Semiconductor
- WP2-20 Top-Gate Oxide Thin-Film Transistors using Solution-Processed Gate Stack of PVP/Al-Zn-Sn-O with an Al₂O₃ Capping Layer for Full-Patterning Process**
저자: Kyeong-Ah Kim, Jun-Yong Bak, and Sung-Min Yoon
소속: Department of Advanced Materials Engineering for Information & Electronics, Kyung Hee University
- WP2-21 Improvements in Bias-Stress Stability Characteristics of Solution-Processed Al-In-Zn-O Thin-Film Transistors with Optimizing the Channel Composition**
저자: Minji Park, Jun-Yong Bak, Jeong-Seon Choi, and Sung-Min Yoon
소속: Department of Advanced Materials Engineering for Information and Electronics, Kyung Hee University
- WP2-22 Thickness and Composition Effects of Al-Doped ZnO Channels Prepared by Atomic Layer Deposition on the Device Behaviors of Oxide Thin-Film Transistors**
저자: Eomji Kim, Jun-Yong Bak, Jeong-Seon Choi, and Sung-Min Yoon
소속: Department of Advanced Materials Engineering for information and Electronics of Engineering, Kyung Hee University
- WP2-23 Effect of Bottom Gate Insulator Thickness on the Threshold-Voltage Tunability and Stress Stabilities of the Fully-Transparent Double-Gate In-Ga-Zn-O TFTs**
저자: Da-Bin Jeon and Sung-Min Yoon
소속: Department of Advanced Materials Engineering for Information and Electronics, Kyung -Hee University

The 21st Korean Conference on Semiconductors
제21회 한국반도체학술대회
February 24–26, 2014 / Hanyang University, Seoul, Korea

[WP2] Poster 3

Date	Feb. 26, 2014 (Wed.)
Place	Room I / 제1공학관 408호 (# 408, Engineering Building I)

- WP2-24 Effects of Ferrite Core Loss and Permeability at 400 kHz Ferrite Inductively Coupled Plasma**
저자: Sung-Won Cho¹, June Young Kim², and Chin-Wook Chung¹
소속: ¹Department of Electrical Engineering, Hanyang University, ²Department of Nanoscale Semiconductor Engineering, Hanyang University
- WP2-25 In-Situ Measurement Method of Dielectric-Film Thickness for Processing Chamber Wall Monitoring**
저자: Jin-Yong Kim and Chin-Wook Chung
소속: Department of Electrical Engineering Hanyang University
- WP2-26 Comparison of Properties of Poly SiGe Deposited by Disilane and Trisilane**
저자: Hyunchul Jang, Sangmo Koo, Byongju Kim, Sun-Wook Kim, and Dae-Hong Ko
소속: Department of Materials Science and Engineering, Yonsei University
- WP2-27 Bipolar Resistive Switching in Amorphous SrTiO₃ Films Grown by Atomic Layer Deposition**
저자: Woongkyu Lee, Kyung Jean Yoon, Woojin Jeon, Yeon Woo Yoo, Cheol Hyun An, and Cheol Seong Hwang
소속: Department of Materials Science and Engineering and Inter-university Semiconductor Research Center, Seoul National University
- WP2-28 Distribution of Plasma Parameters at Wafer Level Measured by 2D Plasma Parameter Diagnostic Method in Inductively Coupled Plasmas**
저자: Young-Cheol Kim¹, and Chin-Wook Chung¹
소속: ¹Department of Nanoscale Semiconductor Engineering, Hanyang University
- WP2-29 Characteristics of Grain Boundary and Interface Traps in Polysilicon Channel Thin Film Transistors**
저자: Yoonseok Jeon, Musarrat Hasan, Cuong Nguyen Manh, Seung-Won You, Duc-Tai Tong, Dong-Hwi Lee, Jae-Kyung Jeong and Rino Choi
소속: Inha University
- WP2-30 Stress Induced Leakage Current Characteristic of La-Incorporated HfO₂ Gate Dielectric**
저자: Seung-won You, Musarrat Hasan, Manh Cuong Nguyen, Yoon Seok Jeon, Duc-Tai Tong, Dong-Hwi Lee, Jae Kyoung Jung and Rino Choi
소속: Department of Materials Science and Engineering, Inha University
- WP2-31 A Study on the Enlargement of the Plasma Reactor using a Global Model**
저자: Dong-Hwan Kim¹, Young-Kwang Lee², and Chin-Wook Chung²
소속: ¹Department of Nanoscale Semiconductor Engineering, Hanyang University, ²Department of Electrical Engineering, Hanyang University

The 21st Korean Conference on Semiconductors
제21회 한국반도체학술대회
February 24–26, 2014 / Hanyang University, Seoul, Korea

[WP2] Poster 3

Date	Feb. 26, 2014 (Wed.)
Place	Room I / 제1공학관 408호 (# 408, Engineering Building I)

- WP2-32 Conduction Mechanism of Metal-Oxide-Semiconductor Field Effect Transistor with La – Incorporated Hf Based Dielectric**
저자: Dong-Hwi Lee, Musarrat Hasan, Manh-Cuong Nguyen, Yoon-Seok Jeon, Seung-Won You, Duc-Tai Tong, Jae-Kyoung Jeong, and Rino Choi
소속: School of Materials Science and Engineering Inha University
- WP2-33 Optimization of GZO/Ag/GZO Multilayer Electrodes Obtained by Pulsed Laser Deposition at Room Temperature**
저자: Eunyoung Cheon, Sang Woo Song, Hwan Sun Kim, Dae Hui Cho, Ji Hun Jang, and Byung Moo Moon
소속: Department of Electrical Engineering, Korea University
- WP2-34 Characteristics of Solution Based Oxide TFT with Solution Heating**
저자: Sang-A Oh¹, Kyeong Min Yu¹, So-Hyun Jeong¹, Eui-Jung Yun², and Byung-Seong Bae¹
소속: ¹Department of Display Engineering, Hoseo University, ²College of IT Engineering and System Control Engineering, Hoseo University
- WP2-35 A Study of Advanced AI RDL Development**
저자: Koeun Cheon, Yonji Park, Yongkuk Kim, Sungwon Yoon, Sangjae Kim, Minki Son, Junhyun Cho, Pilsoon Bae, Jaesung Oh, Jaemyun Kim, and Kwangyoo Byun
소속: SK hynix
- WP2-36 Effect of ALD Grown Aluminum Oxide Film on the IGZO TFT**
저자: Heeok Kim¹, Jong-Heon Yang, Sung Haeng Cho, Minki Ryu, Jae-Eun Pi, Jong-Woo Kim, Oh Sang Kwon, Eun Suk Park, Chi-Sun Hwang, and Sang-Hee Ko Park
소속: Oxide TFT Research Section, Electronics and Telecommunications Research Institute
- WP2-37 Suppression of Current Collapse Effect by Insertion of Mo on Ni/Au Based Schottky Contacts in AlGaIn/GaN HEMT**
저자: Su-Keun Eom, Neung-Hee Lee, and Kwang-Seok Seo
소속: Department of Electrical and Computer Engineering, Seoul National University
- WP2-38 Improvement of Device Characteristic on Solution-Processed InGaZnO Pseudo Metal-Oxide-Semiconductor Field-Effect-Transistor using Microwave Annealing.**
저자: Sung-Wan Moon, Ja-Gyeong Gu, and Won-Ju Cho
소속: Department of Electronic Materials Engineering, Kwangwoon University
- WP2-39 Effect of Baking Temperature on Device Characteristics in TFT based Solution Processed Amorphous ZnSnO**
저자: Kwang-Won Cho, Young-Hyun Hwang, and Won-Ju Cho
소속: Department of Electrical Material Engineering, Kwangwoon University

The 21st Korean Conference on Semiconductors
제21회 한국반도체학술대회
February 24–26, 2014 / Hanyang University, Seoul, Korea

[WP2] Poster 3

Date	Feb. 26, 2014 (Wed.)
Place	Room I / 제1공학관 408호 (# 408, Engineering Building I)

- WP2-40 선택적 리세스 게이트 소자의 공정 및 특성 분석**
저자: 김정진^{1,2}, 박영락¹, 고상춘¹, 문재경¹, 장우진¹, 장우영¹, 배성범¹, 양전욱²
소속: ¹한국전자통신연구원, ²전북대학교 반도체화학공학부
- WP2-41 Electrical Characteristics and Instability of Solution-Derived An-Zn-Sn-O Thin-Film Transistors**
저자: Yeong-Hyeon Hwang and Won-Ju Cho
소속: Department of Electronic Materials Engineering, Kwangwoon University
- WP2-42 Systematic Analysis of Electrical Traps at Surface, AlGa_N Barrier, and GaN Buffer of AlGa_N/Ga_N HFET Device**
저자: Seung Yup Jang¹, Jong-Hoon Shin¹, Myeong-Kyu Eo², Hyo-Seung Choi², Hyuck-In Kwon², and TaeHoon Jang¹
소속: ¹IGBT part, System IC R&D Laboratory, LG Electronics, ²School of Electronic and Electrical Engineering, Chung-Ang University
- WP2-43 RF Characteristics of GaN on SiC for Different Device Topology**
저자: Youngrak Park, Woojin Jang, Sangchoon Ko, Jungjin Kim, Wooyoung Jang, Sungbum Bae, Jongwon Lim, Hokyun Ahn, and Jaekyung Mun
소속: GaN Power Electronics Research Section, Electronics and Telecommunications Research Institute
- WP2-44 에피텍셀 방법으로 성장된 In-Situ SiN 의 Surface Trap 감소 효과 연구**
저자: 조성무, 황의진, 김재무, 김준호, 장태훈
소속: LG전자 System, IC 연구소 IGBT Part
- WP2-45 Structural Optimization of Field-Plated Normally-off AlGa_N/Ga_N-on-Si MOSHFETs**
저자: Jae-Gil Lee, Bong-Ryeol Park, and Ho-Young Cha
소속: School of Electronic and Electrical Engineering, Hongik University
- WP2-46 Effect of Basal-Plane Stacking Faults on X-Ray Diffraction of Nonpolar a-Plane GaN Films**
저자: Ji Hoon Kim¹, Sung-Min Hwang², Kwang Hyeon Baik³, and Jung Ho Park¹
소속: ¹School of Electrical Engineering, Korea University, ²Photonics Convergence Research Center, Korea Electronics Technology Institute, ³Department of Materials Science and Engineering, Hongik University
- WP2-47 Ammonium Polysulfide Passivation for Interface between GaN and Atomic-Layer-Deposited HfAlO_x**
저자: Donghwan Lim, Woosuk Jung, and Changhwan Choi
소속: Division of Materials Science & Engineering, Hanyang University
- WP2-48 A Study on Crystalline ZnTe Channel Characteristics for Thin Film Transistor Device**
저자: Yoonki Min, Jonggi Kim, Heedo Na, and Hyunchul Sohn
소속: Department of Materials Science & Engineering, Yonsei University

The 21st Korean Conference on Semiconductors
제21회 한국반도체학술대회
February 24–26, 2014 / Hanyang University, Seoul, Korea

[WP2] Poster 3

Date	Feb. 26, 2014 (Wed.)
Place	Room I / 제1공학관 408호 (# 408, Engineering Building I)

- WP2-49 Study of N-contact Hole Number of Via Hole Vertical LEDs for Electrical and Optical Properties**
저자: Chi Gyun Song¹, Hyung-Jo Park², Tak Jeong², Sang Hern Lee², and Joon Seop Kwak¹
소속: ¹Department of Printed Electronics Engineering, Sunchon National University, ²LED Device Team, Korea Photonics Technology Institute
- WP2-50 Growth of Semi-Insulating C-Doped/Undoped GaN Multiple-Layer Buffer**
저자: Chul-Ho Won, Sang-Min Jeon, Dong-Seok Kim, Soo-Jin Yu, Hee-Sung Kang, Young-Woo Jo, Do-Kywn Kim, Ryun-Hwi Kim, Dong-Hyeok Son, You-Mi Kwon, Vodapally Sindhuri, Jun-Hyeok Lee, Ji-Hyun Kim, Young-Jo Kim, and Jung-Hee Lee
소속: School of Electronics Engineering, Kyungpook National University
- WP2-51 Suppression of Current Collapse in AlGaIn/GaN MISFET with a Novel Buffer Structure**
저자: Young-Jo Kim, Hee-Sung Kang, Dong-Seok Kim, Young-Woo Jo, Do-Kywn Kim, You-Mi Kwon, Dong-Hyeok Son, Ji-Hyun Kim, Jun-Hyeok Lee, Young Jun Yoon, Yong Soo Lee, and Jung-Hee Lee
소속: School of Electronics Engineering, Kyungpook National University
- WP2-52 Characteristics of AlGaIn/GaN HEMTs on SiC with Pt-Based Schottky Contacts**
저자: Hyung Sup Yoon, Byoung Gue Min, Ho Kyun Ahn, Jong Min Lee, Dong Min Kang, Sung Il Kim, Chul Won Ju, Hae Cheon Kim, and Jong Won Lim
소속: RF Convergence Components Research Section, IT Components & Materials Research Laboratory, Electronics and Telecommunications Research Institute
- WP2-53 Bias-dependent Characteristics of AlGaIn/GaN HEMTs on SiC with T-Shaped Gate of 0.25 μ m Gate Length**
저자: Jong-Min Lee, Byoung-Gue Min, Hyung Sup Yoon, Ho-Kyun Ahn, Dong Min Kang, Seong Il Kim, Sang-Heung Lee, Chul Won Ju, Hae Cheon Kim, and Jong-Won Lim
소속: RF Convergence Components Research Section, IT Materials and Components Lab., Electronics and Telecommunications Research Institute
- WP2-54 A Study on the Scalability of a Threshold Type Cell Select Device using Amorphous GeSe, and the Experimental Ways for Reduction of Threshold Voltage**
저자: Hyung-Woo Ahn, Suyoun Lee, Doo Seok Jeong, Sang-Yeol Shin, and Byung-ki Cheong
소속: Electronic Materials Research Center, Korea Institute of Science and Technology

The 21st Korean Conference on Semiconductors
제21회 한국반도체학술대회
February 24–26, 2014 / Hanyang University, Seoul, Korea

[WP2] Poster 3

Date	Feb. 26, 2014 (Wed.)
Place	Room I / 제1공학관 408호 (# 408, Engineering Building I)

- WP2-55 Dependence of Output Power Density on Gate width of AlGaIn/GaN HEMT on SiC Substrate at 9.3GHz**
저자: Byoung-Gue Min, Hyung Sup Yoon, Ho-Kyun Ahn, Seong-Il Kim, Jong-Min Lee, Haecheon Kim, Dong-Min Kang, Chul-Won Ju, Sang-Heung Lee, and Jong-Won Lim
소속: RF Convergence Components Research Section, IT Components & Materials Research Laboratory, Electronics and Telecommunications Research Institute
- WP2-56 RF Performance of 13 nm-thick AlGaIn/GaN HEMT with Thin Al₂O₃ Surface Protection Layer**
저자: Jun-Hyeok Lee¹, Ryun-Hwi Kim¹, Do-Kywn Kim¹, Chul-Ho Won¹, Ji-Hyun Kim¹, Young-Jo Kim¹
Bok-Hyung Lee², Byeong-Ok Lim², Gil-Wong Choi², In-Pyo Hong³, and Jung-Hee Lee¹
소속: ¹School of Electronics Engineering, Kyungpook National University, ²Samsung Thales Co., Ltd, Korea, ³Agency for Defense Development
- WP2-57 Ultra-Violet Sensitivity of n-ZnO/p-GaN Hetero-junction Diode**
저자: Seong Gook Cho, Woong Tak Moon, and Eun Kyu Kim
소속: Department of Physics and Research Institute for Natural Sciences, Hanyang University,
- WP2-58 Photoluminescence Anisotropy in InP Quantum Dot Strings**
저자: Yongmin Kim¹, Yong Ho Shin¹, and Jindong Song²
소속: ¹Department of Applied Physics and Institute of Nanoscience and Biotechnology, Dankook University
- WP2-59 Optical Study of Non-polar a-Axis ZnO Single Crystal for Light Emitting Applications**
저자: Younghun Hwang and Youngho Um
소속: Department of Physics, University of Ulsan
- WP2-60 Unusual Photoluminescence Peak Shift of InSb Epitaxial Layers Grown by LP-MOCVD**
저자: Jinwook Jung¹, Sehun Park¹, Chulkyun Seok¹, Yongjo Park², Xiren Chen³, Jun Shao³, and Euijoon Yoon¹
소속: ¹Department of Materials Science and Engineering, Seoul National University, ²Energy Semiconductor Research Center, Advanced Institutes of Convergence Technology, Seoul National University, ³Shanghai Institute of Technical Physics, Chinese Academy of Sciences
- WP2-61 A Design of Transceiver for Advanced UHF Band RFID Reader**
저자: Hyo-Bin Jung, Won-Jae Jung, Sang-Kyu Kim, Se-Mi Lim, Ji-Hoon Lee, Kyu-Hyun Nam, and Jun-Seok Park
소속: School of Electrical Engineering, Kookmin University

The 21st Korean Conference on Semiconductors
제21회 한국반도체학술대회
February 24–26, 2014 / Hanyang University, Seoul, Korea

[WP2] Poster 3

Date	Feb. 26, 2014 (Wed.)
Place	Room I / 제1공학관 408호 (# 408, Engineering Building I)

- WP2-62 A Pipelined Digital Predistorter using CORDIC Processor**
저자: Jong Kang Park, Kyunghoon Kim, Youngoo Yang, and Jong Tae Kim
소속: School of Electronic and Electrical Engineering, Sungkyunkwan University
- WP2-63 Spectroscopic Ellipsometer를 이용한 CVD Graphene 의 광학특성 평가**
저자: 손우식¹, 문정훈², 현문섭¹, 양준모¹, 조병진²
소속: ¹나노종합기술원 특성평가사업실, ²한국과학기술원 전기전자공학과
- WP2-64 Monte Carlo Simulation of Scanning Electron Microscopic Images of Specimens for Structural and Compositional Analysis**
저자: Myeong Chun Song and Jin Seung Kim
소속: Department of Nano Science and Technology, Graduate School, Chonbuk National University
- WP2-65 Electronic Structure of Graphene: EELS and DFT Calculation**
저자: Yun Chang Park and Jun-Mo Yang
소속: National NanoFab Center
- WP2-66 유성펜을 이용한 FIB 손상 방지용 보호층 증착 및 특성**
저자: 박윤창¹, 박병천², Sergey Romankov³, 박경진¹, 유정호¹, 이용복¹, 양준모¹
소속: ¹나노종합기술원, ²한국표준과학연구원, ³전북대학교 신소재공학과
- WP2-67 집속이온빔(FIB)을 이용한 GaN 계 LED 의 3 차원 전위분석**
저자: 박경진, 광상희, 유정호, 박윤창, 양준모
소속: 나노종합기술원 특성평가실
- WP2-68 전계방출 전자빔의 전자광학계 정렬기술 연구**
저자: 최성웅¹, 이영복¹, 김대욱¹, 오택식¹, 김영정², 김호섭¹
소속: ¹선문대학교 나노과학과, ²선문대학교 신소재공학과
- WP2-69 회절광 현미경을 이용한 극자외선 마스크의 이미징 성능측정**
저자: 이재욱¹, 홍성철¹, 이승민¹, 김종석², 정시준³, 김정식⁴, 안진호^{1,2,3,4}
소속: ¹한양대학교 신소재공학과, ²한양대학교 정보디스플레이공학과, ³한양대학교 나노융합학과, ⁴한양대학교 나노반도체공학과
- WP2-70 GPA를 이용한 Strained Silicone의 응력분포 해석에 대한 시편제작 방법의 영향**
저자: 이용복, 박윤창, 유정호, 박경진, 이완규, 양준모
소속: 나노종합기술원 특성평가실
- WP2-71 고속 검사를 위한 멀티전자빔 검사장비 연구**
저자: 이승범¹, 정원영¹, 조현우¹, 이준호¹, 이영복², 최성웅², 김대욱², 오택식², 김호섭²
소속: ¹LIG 에이디피, ²선문대학교 나노과학과

The 21st Korean Conference on Semiconductors
제21회 한국반도체학술대회
February 24–26, 2014 / Hanyang University, Seoul, Korea

[WP2] Poster 3

Date	Feb. 26, 2014 (Wed.)
Place	Room I / 제1공학관 408호 (# 408, Engineering Building I)

WP2-72 대면적 스캔을 위한 **Quadrupole Einzel Lens** 구조 연구

저자: 이영복, 김대욱, 오탉식, 김호섭

소속: 선문대학교 나노과학과

WP2-73 멀티 전자칼럼 제어방식에 대한 연구

저자: 이순용^{1,2}, 임선종¹, 김호섭²

소속: ¹한국기계연구원 광응용기계연구실, ²선문대학교 나노과학과